

Notice of References Cited	Application/Control No. 10/791,155	Applicant(s)/Patent Under Reexamination LAVIE ET AL.
	Examiner Lei Yao, Ph.D.	Art Unit 1642

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
	U	Zhu et al., JBC, vol 275, page 26727, 2000, abstract.		
	V			
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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